**ON Semiconductor** 

Is Now

# Onsemi

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# **FETKY**<sup>™</sup> Power MOSFET and Schottky Diode Dual SO–8 Package

### Features

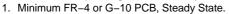
- High Efficiency Components in a Single SO-8 Package
- High Density Power MOSFET with Low R<sub>DS(on)</sub>, Schottky Diode with Low V<sub>F</sub>
- Logic Level Gate Drive
- Independent Pin–Outs for MOSFET and Schottky Die Allowing for Flexibility in Application Use
- Less Component Placement for Board Space Savings
- SO-8 Surface Mount Package, Mounting Information for SO-8 Package Provided
- Pb–Free Package is Available

### Applications

• Power Management in Portable and Battery–Powered Products, i.e.: Computers, Printers, PCMCIA Cards, Cellular and Cordless Telephones

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V <sub>DSS</sub>	-20	V
Gate-to-Source Voltage - Continuous	V <sub>GS</sub>	±10	V
Thermal Resistance, Junction–to–Ambient (Note 1) Total Power Dissipation @ $T_A = 25^{\circ}C$ Continuous Drain Current @ $T_A = 25^{\circ}C$ Continuous Drain Current @ $T_A = 100^{\circ}C$ Pulsed Drain Current (Note 4)	R <sub>θJA</sub> P <sub>D</sub> I <sub>D</sub> I <sub>DM</sub>	175 0.71 -2.3 -1.45 -9.0	°C/W W A A A
Thermal Resistance, Junction–to–Ambient (Note 2) Total Power Dissipation @ $T_A = 25^{\circ}C$ Continuous Drain Current @ $T_A = 25^{\circ}C$ Continuous Drain Current @ $T_A = 100^{\circ}C$ Pulsed Drain Current (Note 4)	R <sub>θJA</sub> P <sub>D</sub> I <sub>D</sub> I <sub>D</sub>	105 1.19 -2.97 -1.88 -12	°C/W W A A A
Thermal Resistance, Junction-to-Ambient (Note 3) Total Power Dissipation @ $T_A = 25^{\circ}C$ Continuous Drain Current @ $T_A = 25^{\circ}C$ Continuous Drain Current @ $T_A = 100^{\circ}C$ Pulsed Drain Current (Note 4)	R <sub>θJA</sub> P <sub>D</sub> I <sub>D</sub> I <sub>DM</sub>	62.5 2.0 -3.85 -2.43 -15	°CW W A A A
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C
	E <sub>AS</sub>	350	mJ
Maximum Lead Temperature for Soldering Purposes, 1/8" from Case for 10 Seconds	ΤL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.



- Mounted onto a 2" square FR-4 Board (1" sq. 2 oz Cu 0.06" thick single sided), Steady State.
- 3. Mounted onto a 2″ square FR–4 Board (1″ sq. 2 oz Cu 0.06″ thick single sided), t  $\leq$  10 seconds.
- 4. Pulse Test: Pulse Width = 300 μs, Duty Cycle = 2%.

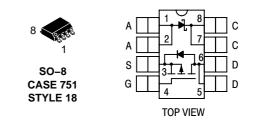


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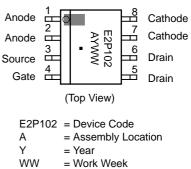
http://onsemi.com

# MOSFET -2.3 AMPERES, -20 VOLTS 90 mΩ @ V<sub>GS</sub> = -4.5 V

# SCHOTTKY DIODE 2.0 AMPERES, 20 VOLTS 580 mV @ I<sub>F</sub> = 2.0 A



### MARKING DIAGRAM & PIN ASSIGNMENTS



= Pb-Free Package

### ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>
NTMSD2P102LR2	SO-8	2500/Tape & Reel
NTMSD2P102LR2G	SO-8 (Pb-Free)	2500/Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

### **SCHOTTKY MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Reverse Voltage DC Blocking Voltage	V <sub>RRM</sub> V <sub>R</sub>	20	V
Average Forward Current (Note 5) (Rated $V_R$ , $T_A = 100^{\circ}$ C)	Io	1.0	A
Peak Repetitive Forward Current (Note 5) (Rated V <sub>R</sub> , Square Wave, 20 kHz, T <sub>A</sub> = 105°C)	I <sub>FRM</sub>	2.0	A
Non-Repetitive Peak Surge Current (Note 5) (Surge Applied at Rated Load Conditions, Half-Wave, Single Phase, 60 Hz)	I <sub>FSM</sub>	20	A

### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted) (Note 6)

Characteristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS					
Drain-to-Source Breakdown Voltage ( $V_{GS} = 0 \text{ Vdc}, I_D = -250 \mu \text{Adc}$ ) Temperature Coefficient (Positive)	V <sub>(BR)</sub> DSS	-20 -	_ -12.7	-	Vdc mV/°C
Zero Gate Voltage Drain Current $(V_{DS} = -16 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T_J = 25^{\circ}\text{C})$ $(V_{DS} = -16 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T_J = 125^{\circ}\text{C})$	I <sub>DSS</sub>			-1.0 -25	μAdc
Zero Gate Voltage Drain Current ( $V_{GS} = 0 \text{ Vdc}, V_{DS} = -20 \text{ Vdc}, T_J = 25^{\circ}\text{C}$ )	I <sub>DSS</sub>	-	-	-2.0	μAdc
Gate-Body Leakage Current (V <sub>GS</sub> = -10 Vdc, V <sub>DS</sub> = 0 Vdc)	I <sub>GSS</sub>	-	-	-100	nAdc
Gate-Body Leakage Current (V <sub>GS</sub> = +10 Vdc, V <sub>DS</sub> = 0 Vdc)	I <sub>GSS</sub>	_	_	100	nAdc
ON CHARACTERISTICS					
Gate Threshold Voltage $(V_{DS} = V_{GS}, I_D = -250 \mu Adc)$ Temperature Coefficient (Negative)	V <sub>GS(th)</sub>	-0.5 -	-0.90 2.5	-1.5 -	Vdc mV/°C
Static Drain-to-Source On-State Resistance ( $V_{GS} = -4.5$ Vdc, $I_D = -2.4$ Adc) ( $V_{GS} = -2.7$ Vdc, $I_D = -1.2$ Adc) ( $V_{GS} = -2.5$ Vdc, $I_D = -1.2$ Adc)	R <sub>DS(on)</sub>	_ _ _	0.070 0.100 0.110	0.090 0.130 0.150	Ω
Forward Transconductance ( $V_{DS} = -10 \text{ Vdc}, I_D = -1.2 \text{ Adc}$ )	9fs	_	4.2	-	Mhos

### DYNAMIC CHARACTERISTICS

Input Capacitance		C <sub>iss</sub>	-	550	750	pF
Output Capacitance	$(V_{DS} = -16 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, f = 1.0 \text{ MHz})$	C <sub>oss</sub>	-	200	300	
Reverse Transfer Capacitance		C <sub>rss</sub>	-	100	175	

Mounted onto a 2" square FR-4 Board (1" sq. 2 oz Cu 0.06" thick single sided), t ≤ 10 seconds.
Handling precautions to protect against electrostatic discharge is mandatory.

### ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted) (continued) (Note 7)

C	Symbol	Min	Тур	Max	Unit	
SWITCHING CHARACTERISTICS (Notes 8 & 9)						
Turn-On Delay Time		t <sub>d(on)</sub>	-	10	20	ns
Rise Time	$(V_{DD} = -10 \text{ Vdc}, I_D = -2.4 \text{ Adc},$	tr	-	35	65	
Turn-Off Delay Time	$V_{GS} = -4.5 \text{ Vdc}, R_{G} = 6.0 \Omega$	t <sub>d(off)</sub>	-	33	60	
Fall Time		t <sub>f</sub>	-	29	55	
Turn-On Delay Time		t <sub>d(on)</sub>	-	15	-	ns
Rise Time	(V <sub>DD</sub> = -10 Vdc, I <sub>D</sub> = -1.2 Adc,	t <sub>r</sub>	-	40	-	
Turn-Off Delay Time	$V_{GS} = -2.7 \text{ Vdc}, R_{G} = 6.0 \Omega$	t <sub>d(off)</sub>	-	35	-	
Fall Time		t <sub>f</sub>	-	35	-	
Total Gate Charge		Q <sub>tot</sub>	-	10	18	nC
Gate-Source Charge	$(V_{DS} = -16 \text{ Vdc}, V_{GS} = -4.5 \text{ Vdc}, I_{D} = -2.4 \text{ Adc})$	Q <sub>gs</sub>	-	1.5	-	1
Gate-Drain Charge	]	Q <sub>gd</sub>	-	5.0	-	]

### BODY-DRAIN DIODE RATINGS (Note 8)

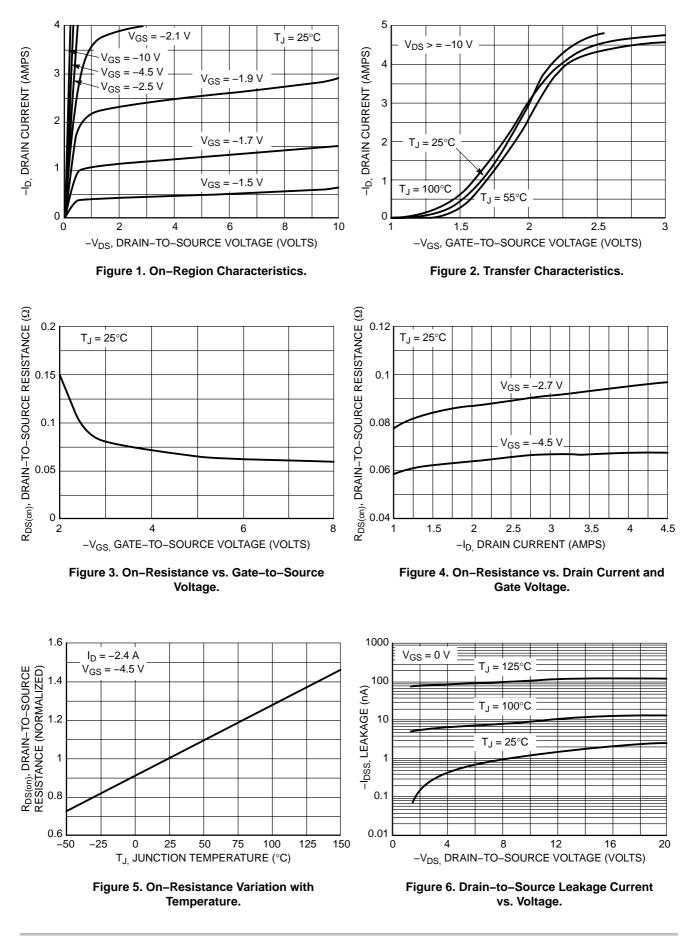
Diode Forward On–Voltage	$(I_{S} = -2.4 \text{ Adc}, V_{GS} = 0 \text{ Vdc})$ $(I_{S} = -2.4 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, T_{J} = 125^{\circ}\text{C})$	V <sub>SD</sub>		-0.88 -0.75	-1.0 _	Vdc
Reverse Recovery Time		t <sub>rr</sub>	-	37	-	ns
	$(I_{S} = -2.4 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, dI_{S}/dt = 100 \text{ A/us})$	t <sub>a</sub>	-	16	-	
		t <sub>b</sub>	-	21	-	
Reverse Recovery Stored Charge		Q <sub>RR</sub>	_	0.025	_	μC

### SCHOTTKY RECTIFIER ELECTRICAL CHARACTERISTICS ( $T_J = 25^{\circ}C$ unless otherwise noted) (Note 8)

Maximum Instantaneous Forward Voltage		VF	T <sub>J</sub> = 25°C	T <sub>J</sub> = 125°C	V
	$I_F = 1.0 \text{ Adc}$ $I_F = 2.0 \text{ Adc}$		0.47 0.58	0.39 0.53	-
Maximum Instantaneous Reverse Current		I <sub>R</sub>	T <sub>J</sub> = 25°C	T <sub>J</sub> = 125°C	mA
	$V_R = 20 Vdc$		0.05	10	
Maximum Voltage Rate of Change	$V_R = 20 \text{ Vdc}$	dV/dt	10,0	V/µs	

7. Handling precautions to protect against electrostatic discharge is mandatory. 8. Indicates Pulse Test: Pulse Width =  $300 \,\mu s \, max$ , Duty Cycle = 2%.

9. Switching characteristics are independent of operating junction temperature.



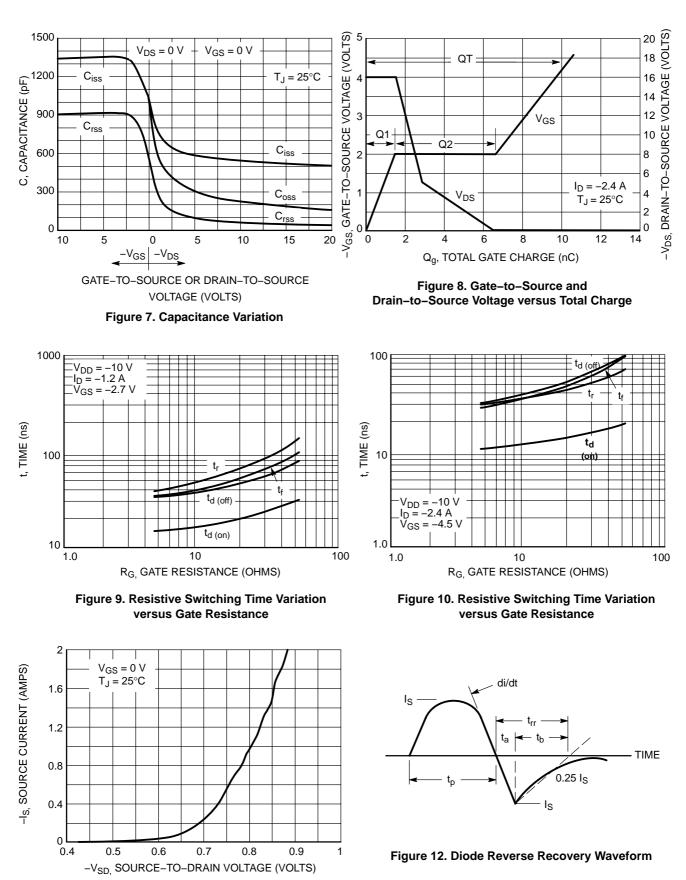


Figure 11. Diode Forward Voltage versus Current

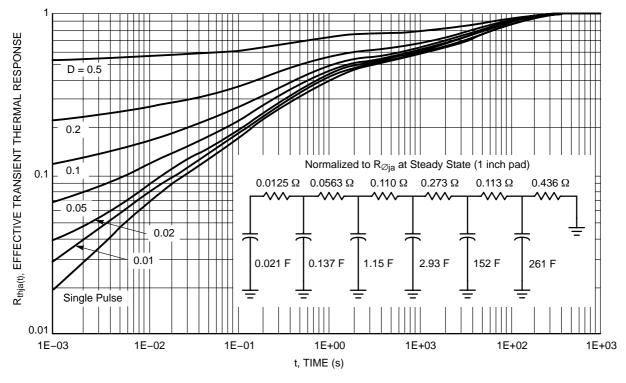
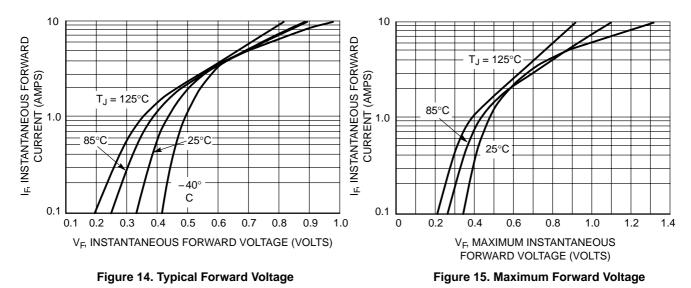
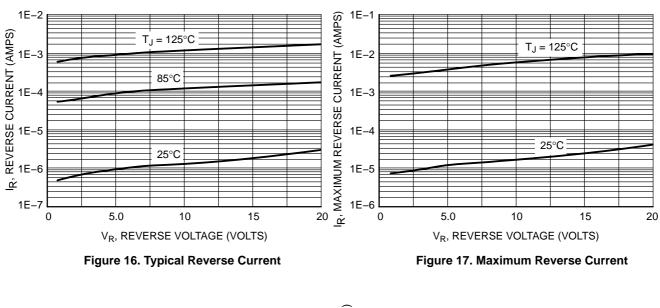


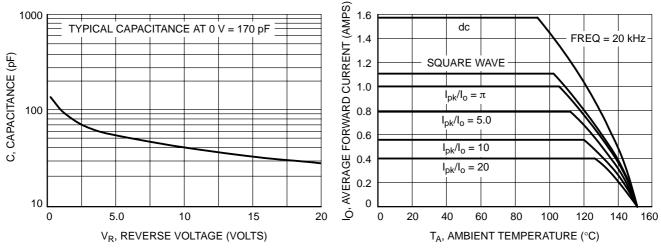
Figure 13. FET Thermal Response

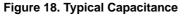
# TYPICAL SCHOTTKY ELECTRICAL CHARACTERISTICS



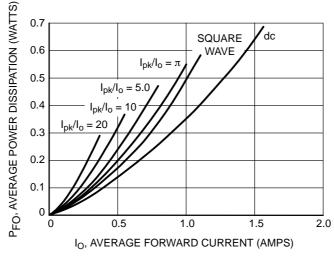


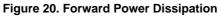
### **TYPICAL SCHOTTKY ELECTRICAL CHARACTERISTICS**

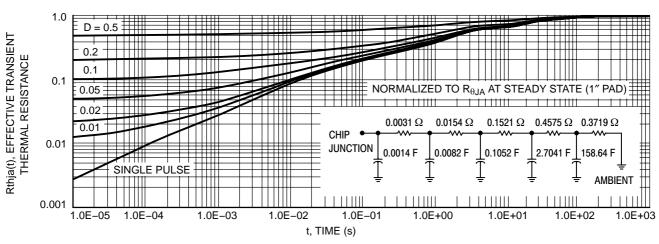










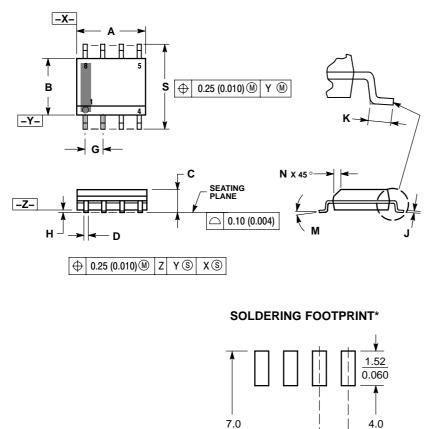


### TYPICAL SCHOTTKY ELECTRICAL CHARACTERISTICS



### PACKAGE DIMENSIONS

SOIC-8 NB CASE 751-07 **ISSUE AH** 



0.275

0.6

0.024

NOTES

- 1. DIMENSIONING AND TOLERANCING PER
- 2
- 3.
- DIMENSIONING AND TOLERANCING PER ANSI Y14-5M, 1982. CONTROLLING DIMENSION: MILLIMETER. DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION. MAXIMUM MOLD PROTRUSION 0.15 (0.006) 4 PER SIDE
- DIMENSION D DOES NOT INCLUDE DAMBAR 5. PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07

	MILLIN	IETERS	INC	HES
DIM	MIN	MAX	MIN	MAX
Α	4.80	5.00	0.189	0.197
В	3.80	4.00	0.150	0.157
С	1.35	1.75	0.053	0.069
D	0.33	0.51	0.013	0.020
G	1.27	7 BSC	0.05	0 BSC
н	0.10	0.25	0.004	0.010
J	0.19	0.25	0.007	0.010
κ	0.40	1.27	0.016	0.050
М	0 °	8 °	0 °	8 °
Ν	0.25	0.50	0.010	0.020
s	5.80	6.20	0.228	0.244

### STYLE 18:

ANODE PIN 1. 2. ANODE

- З. SOURCE
- 4 GATE
- DRAIN 5
- 6. DRAIN 7 CATHODE

mm )

inches

SCALE 6:1

8. CATHODE

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

0.155

1.270

0.050

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